

SLD3101

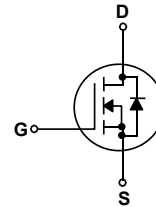
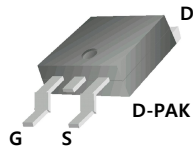
430V N-Channel MOSFET

General Description

This Power MOSFET is produced using Maple semi's advanced trench MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- 11A, 430V, $R_{DS(on)typ.} = 0.55\Omega @ V_{GS} = 10V$
- Low gate charge (typical 23nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	SLD3101	Units
V_{DSS}	Drain-Source Voltage	430	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$)	11	A
I_{DM}	Drain Current - Pulsed (Note 1)	22	A
V_{GSS}	Gate-Source Voltage	± 30	V
EAS	Single Pulsed Avalanche Energy (Note 2)	437	mJ
I_{AR}	Avalanche Current (Note 1)	5.4	A
E_{AR}	Repetitive Avalanche Energy (Note 1)	19.36	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	2.8	V/ns
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	35	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$
$V_{ESD(G-S)}$	Gate Source ESD (HBM - C = 100pF, R = 1.5K Ω)	2500	V

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	SLD3101	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	3.86	$^\circ\text{C/W}$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	$^\circ\text{C/W}$

Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	430	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\text{ }\mu\text{A}$, Referenced to 25°C	--	0.40	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 400\text{ V}, V_{GS} = 0\text{ V}$	--	--	10	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$	--	--	-100	nA

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	2.0	--	4.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 5.5\text{ A}$	--	--	550	m Ω

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$	--	940	--	pF
C_{oss}	Output Capacitance		--	125	--	pF
C_{riss}	Reverse Transfer Capacitance		--	9.5	--	pF

Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 200\text{ V}, I_D = 11\text{ A},$ $R_G = 25\Omega$ (Note 4, 5)	--	19	--	ns
t_r	Turn-On Rise Time		--	70	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	70	--	ns
t_f	Turn-Off Fall Time		--	27	--	ns
Q_g	Total Gate Charge	$V_{DS} = 320\text{ V}, I_D = 11\text{ A}, I_G = 1\text{ mA}$ $V_{GS} = 10\text{ V}$ (Note 4, 5)	--	23	--	nC
Q_{gs}	Gate-Source Charge		--	5.4	--	nC
Q_{gd}	Gate-Drain Charge		--	5	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

I_S	Maximum Continuous Drain-Source Diode Forward Current	--	--	11	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	22	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 11\text{ A}$	--	--	1.4	V
t_{rr}	Reverse Recovery Time	$V_{GS} = 0\text{ V}, I_S = 11\text{ A},$	--	410	--	ns
Q_{rr}	Reverse Recovery Charge	$di_F / dt = 100\text{ A}/\mu\text{s}$ (Note 4)	--	7	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $L = 30\text{ mH}, I_{AS} = 5.4\text{ A}, V_{DD} = 50\text{ V}, R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{SD} \leq 11\text{ A}, di/dt \leq 100\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics

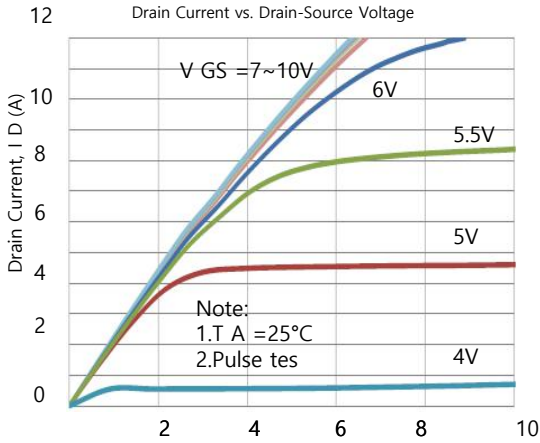


Figure 1. Drain-Source Voltage, V DS (V)

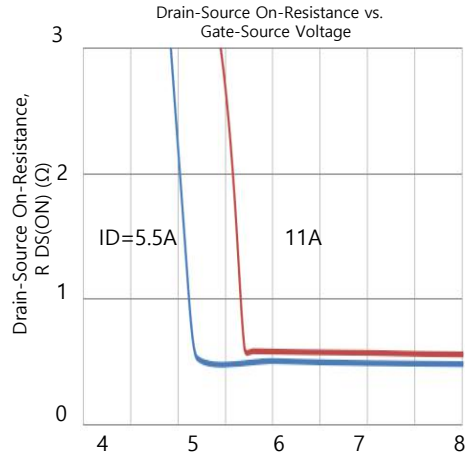


Figure 2. Gate-Source Voltage, V GS (V)

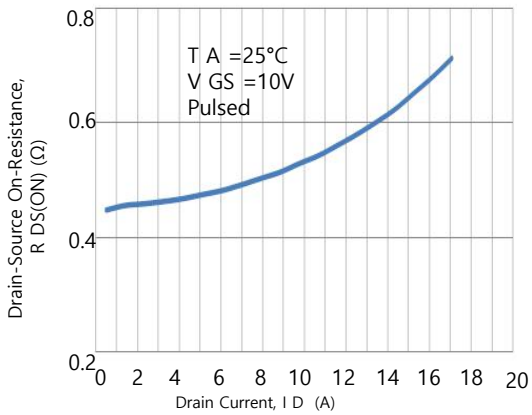


Figure 3. Drain-Source On-Resistance vs. Drain Current

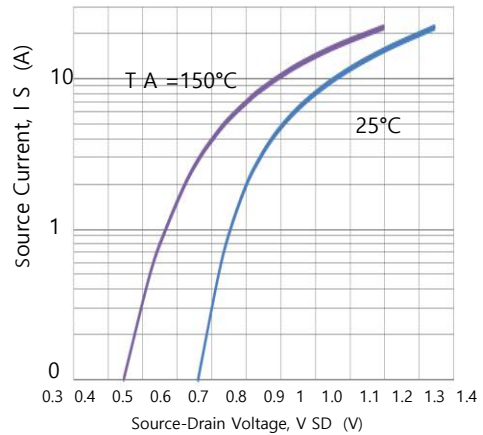


Figure 4. Source Current vs. Source-Drain Voltage

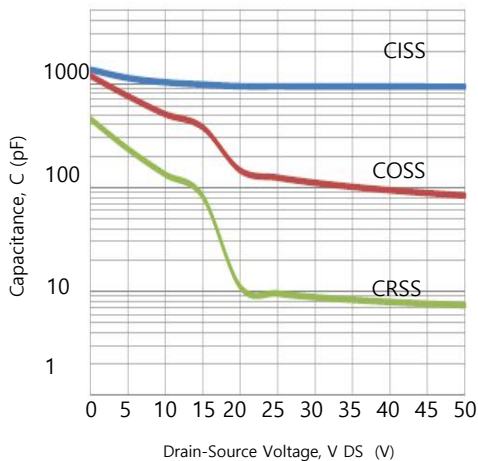


Figure 5. Capacitance Characteristics

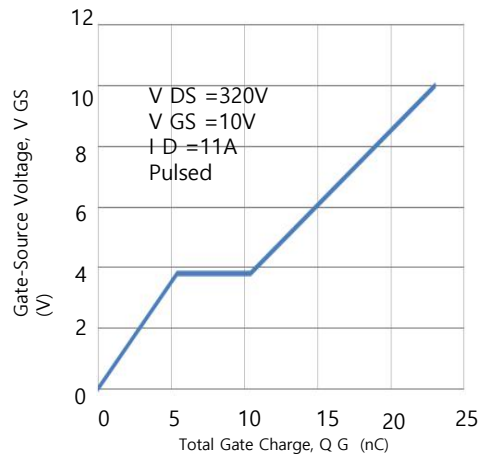


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

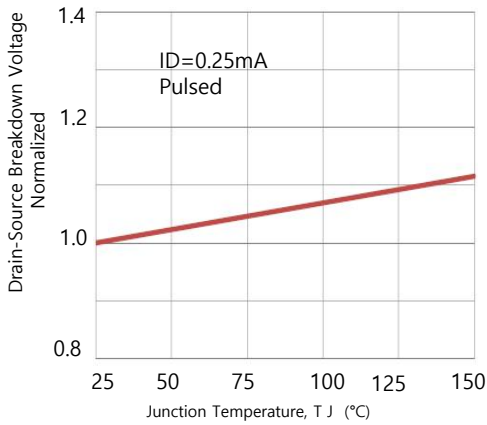


Figure 7. Breakdown Voltage Variation vs Temperature

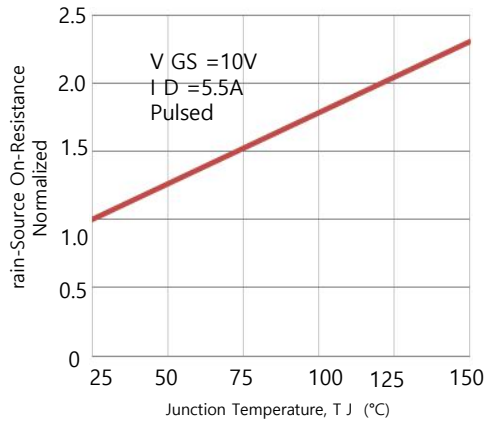


Figure 8. On-Resistance Variation vs Temperature

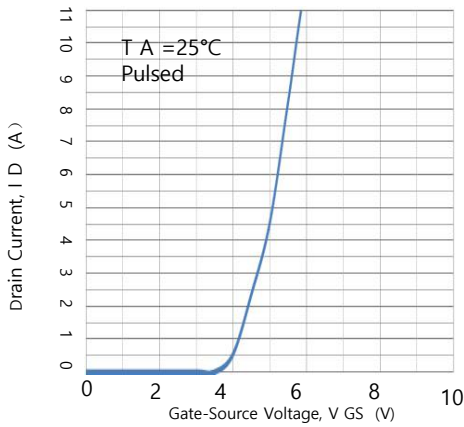


Figure 9 Drain Current vs. Gate-Source Voltage

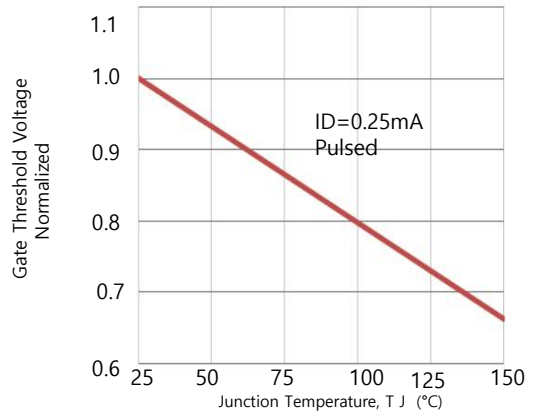


Figure 10 Gate Threshold Voltage vs. Junction Temperature

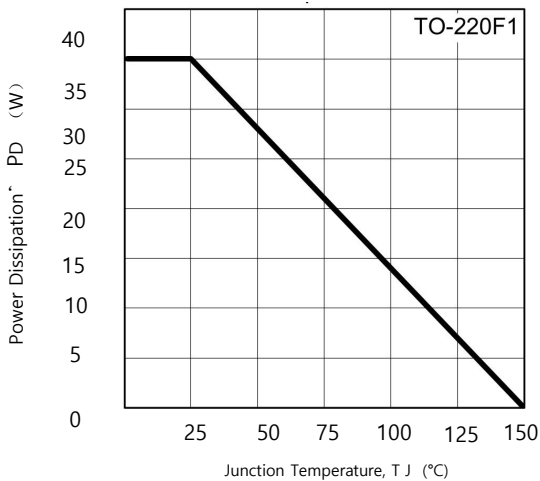


Figure 11. Power Dissipation vs. Junction Temperature

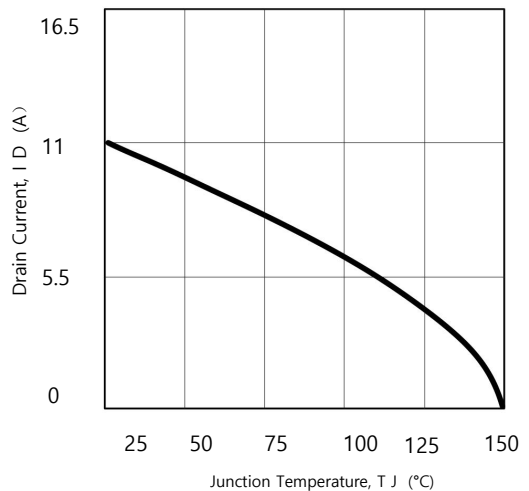


Figure 12. Power Dissipation vs. Junction Temperature

Typical Characteristics (Continued)

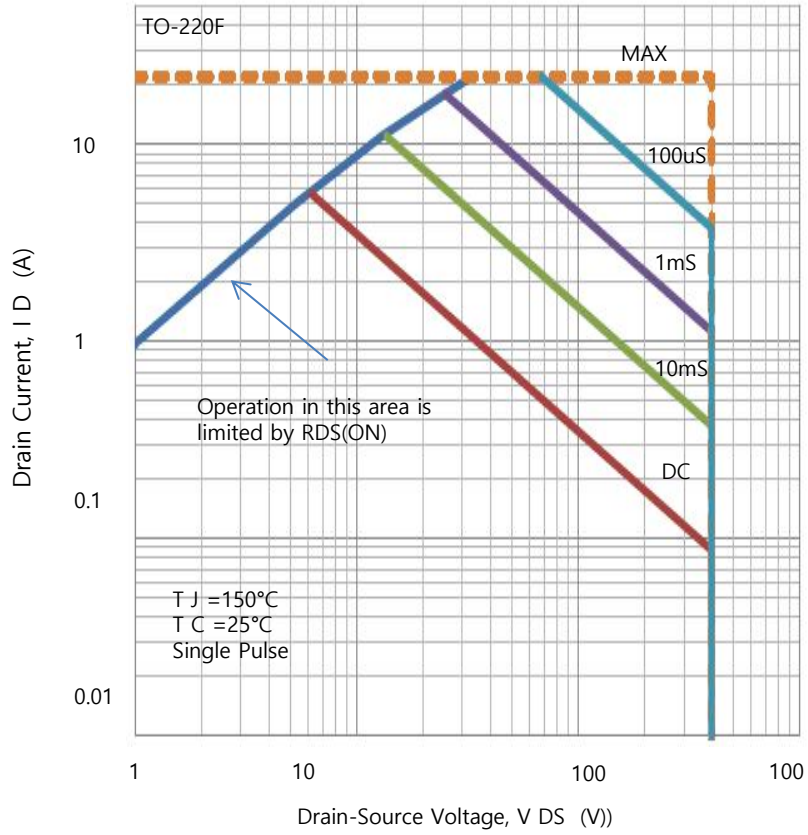
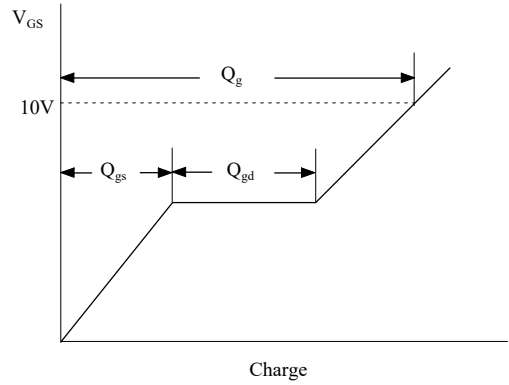
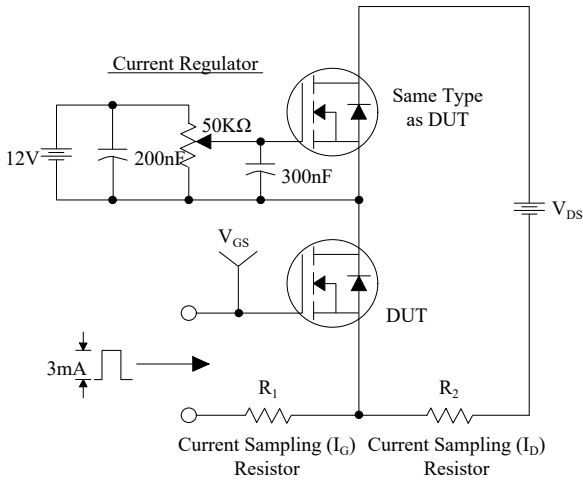
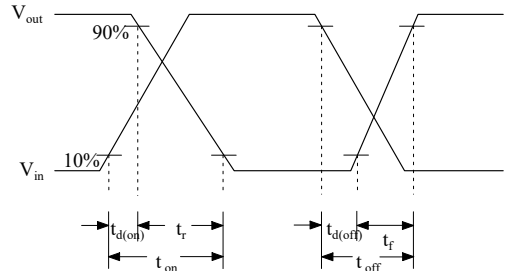
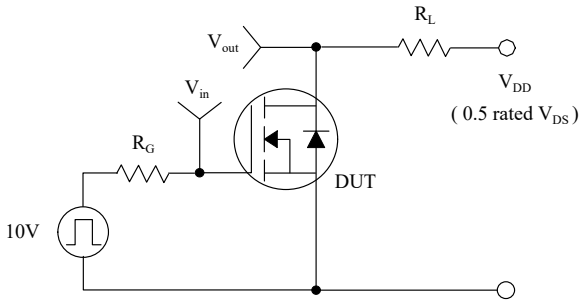


Figure 13 Safe Operating Area

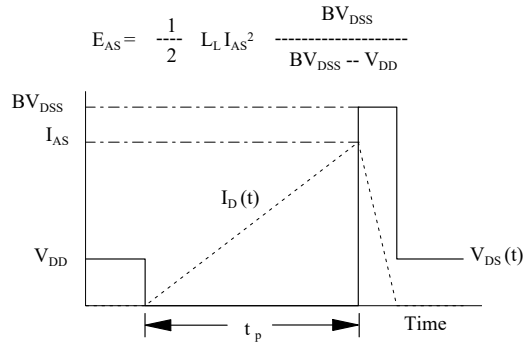
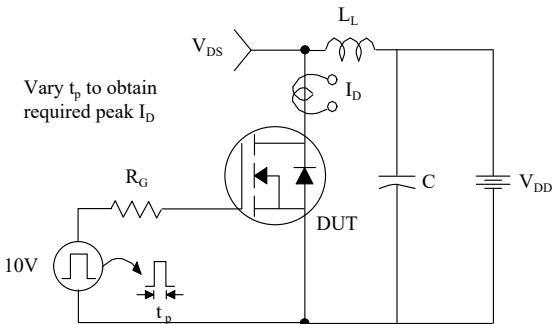
Gate Charge Test Circuit & Waveform



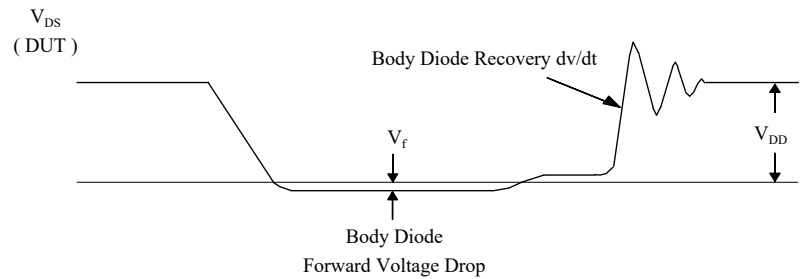
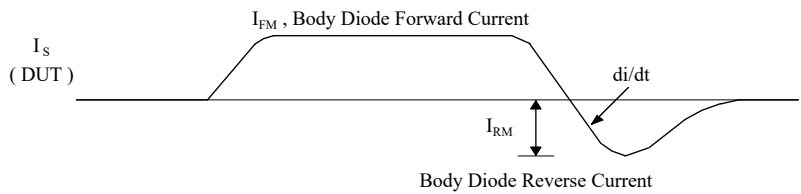
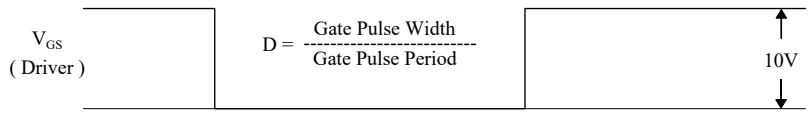
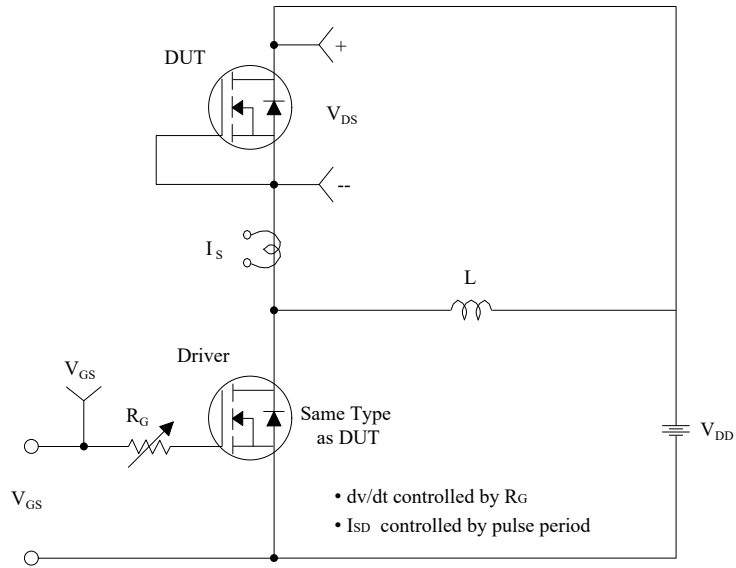
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms



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